



## DOUBLE CHANNEL HIGH SIDE DRIVER

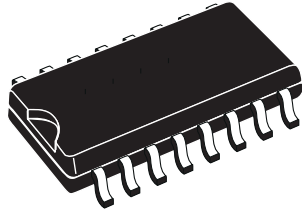
TYPE	R <sub>DS(on)</sub>	I <sub>OUT</sub>	V <sub>CC</sub>
VND810	160 mΩ (*)	3.5 A (*)	36 V

(\*) Per each channel

- CMOS COMPATIBLE INPUTS
- OPEN DRAIN STATUS OUTPUTS
- ON STATE OPEN LOAD DETECTION
- OFF STATE OPEN LOAD DETECTION
- SHORTED LOAD PROTECTION
- UNDERVOLTAGE AND OVERVOLTAGE SHUTDOWN
- PROTECTION AGAINST LOSS OF GROUND
- VERY LOW STAND-BY CURRENT
- REVERSE BATTERY PROTECTION (\*\*)

### DESCRIPTION

The VND810 is a monolithic device designed in STMicroelectronics VIPower M0-3 Technology, intended for driving any kind of load with one side connected to ground. Active V<sub>CC</sub> pin voltage clamp protects the device against low energy spikes (see ISO7637 transient

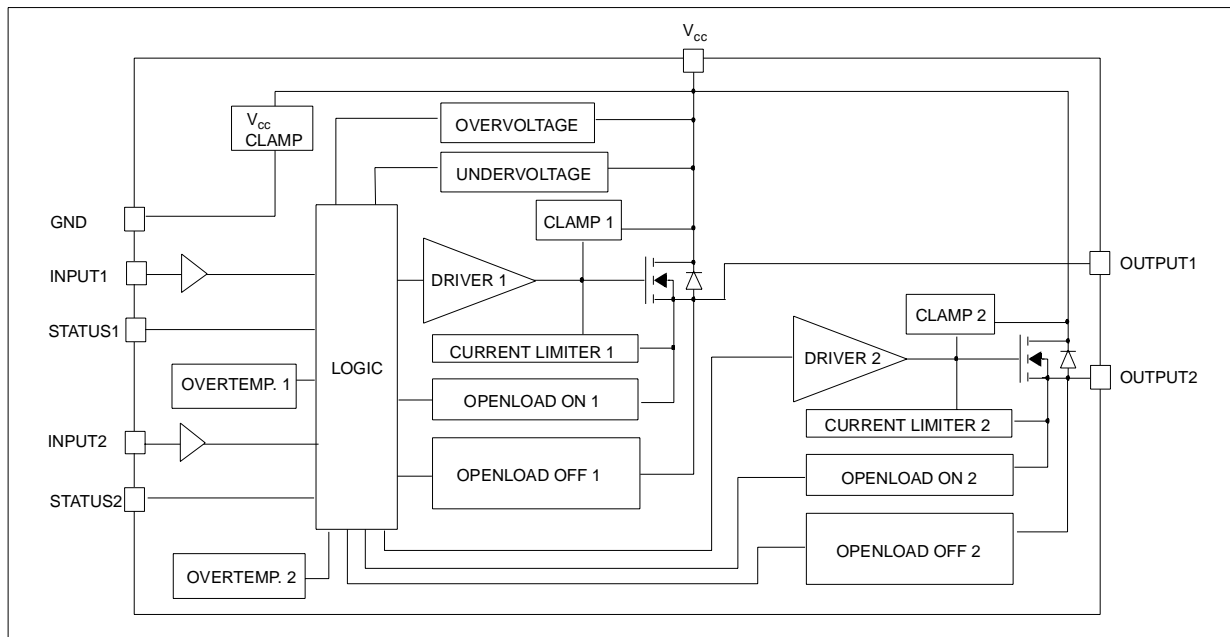


**SO-16**

ORDER CODES		
PACKAGE	TUBE	T&R
SO-16	VND810	VND81013TR

compatibility table). Active current limitation combined with thermal shutdown and automatic restart protects the device against overload. The device detects open load condition both in on and off state. Output shorted to V<sub>CC</sub> is detected in the off state. Device automatically turns off in case of ground pin disconnection.

### BLOCK DIAGRAM



(\*\*) See application schematic at page 8

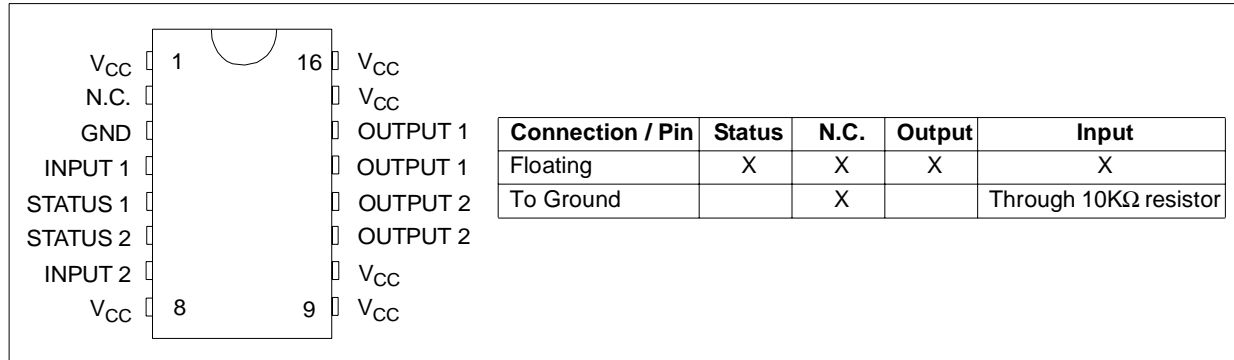
Rev. 1

# VND810

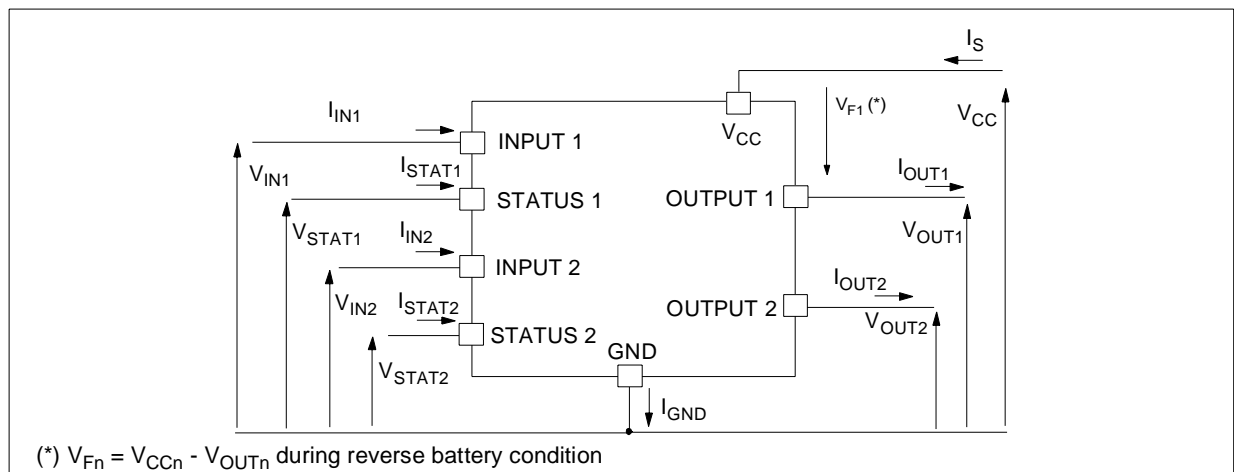
## ABSOLUTE MAXIMUM RATING

Symbol	Parameter	Value	Unit
$V_{CC}$	DC Supply Voltage	41	V
$-V_{CC}$	Reverse DC Supply Voltage	- 0.3	V
$-I_{GND}$	DC Reverse Ground Pin Current	- 200	mA
$I_{OUT}$	DC Output Current	Internally Limited	A
$-I_{OUT}$	Reverse DC Output Current	- 6	A
$I_{IN}$	DC Input Current	+/- 10	mA
$I_{stat}$	DC Status Current	+/- 10	mA
$V_{ESD}$	Electrostatic Discharge (Human Body Model: R=1.5K $\Omega$ ; C=100pF)		
	- INPUT	4000	V
	- STATUS	4000	V
	- OUTPUT	5000	V
	- $V_{CC}$	5000	V
$E_{MAX}$	Maximum Switching Energy (L=1.5mH; R <sub>L</sub> =0 $\Omega$ ; V <sub>bat</sub> =13.5V; T <sub>jstart</sub> =150 $^{\circ}$ C; I <sub>L</sub> =5A)	26	mJ
$P_{tot}$	Power Dissipation T <sub>C</sub> =25 $^{\circ}$ C	8.3	W
$T_j$	Junction Operating Temperature	Internally Limited	$^{\circ}$ C
$T_c$	Case Operating Temperature	- 40 to 150	$^{\circ}$ C
$T_{stg}$	Storage Temperature	- 55 to 150	$^{\circ}$ C

## CONFIGURATION DIAGRAM (TOP VIEW) & SUGGESTED CONNECTIONS FOR UNUSED AND N.C. PINS



## CURRENT AND VOLTAGE CONVENTIONS



## THERMAL DATA

Symbol	Parameter	Value	Unit
R <sub>thj-lead</sub>	Thermal Resistance Junction-lead	15	°C/W
R <sub>thj-amb</sub>	Thermal Resistance Junction-ambient	77 <sup>(1)</sup>   57 <sup>(2)</sup>	°C/W

(1) When mounted on a standard single-sided FR-4 board with 0.5cm<sup>2</sup> of Cu (at least 35µm thick) connected to all V<sub>CC</sub> pins. Horizontal mounting and no artificial air flow.

(2) When mounted on a standard single-sided FR-4 board with 4cm<sup>2</sup> of Cu (at least 35µm thick) connected to all V<sub>CC</sub> pins. Horizontal mounting and no artificial air flow.

ELECTRICAL CHARACTERISTICS (8V < V<sub>CC</sub> < 36V; -40°C < T<sub>j</sub> < 150°C, unless otherwise specified)

(Per each channel)

## POWER OUTPUTS

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V <sub>CC</sub> (**)	Operating Supply Voltage		5.5	13	36	V
V <sub>USD</sub> (**)	Undervoltage Shut-down		3	4	5.5	V
V <sub>OV</sub> (**)	Overvoltage Shut-down		36			V
R <sub>ON</sub>	On State Resistance	I <sub>OUT</sub> =1A; T <sub>j</sub> =25°C I <sub>OUT</sub> =1A; V <sub>CC</sub> >8V			160 320	mΩ mΩ
I <sub>S</sub> (**)	Supply Current	Off State; V <sub>CC</sub> =13V; V <sub>IN</sub> =V <sub>OUT</sub> =0V Off State; V <sub>CC</sub> =13V; V <sub>IN</sub> =V <sub>OUT</sub> =0V; T <sub>j</sub> =25°C On State; V <sub>CC</sub> =13V; V <sub>IN</sub> =5V; I <sub>OUT</sub> =0A		12 12 5	40 25 7	µA µA mA
I <sub>L(off1)</sub>	Off State Output Current	V <sub>IN</sub> =V <sub>OUT</sub> =0V	0		50	µA
I <sub>L(off2)</sub>	Off State Output Current	V <sub>IN</sub> =0V; V <sub>OUT</sub> =3.5V	-75		0	µA
I <sub>L(off3)</sub>	Off State Output Current	V <sub>IN</sub> =V <sub>OUT</sub> =0V; V <sub>CC</sub> =13V; T <sub>j</sub> =125°C			5	µA
I <sub>L(off4)</sub>	Off State Output Current	V <sub>IN</sub> =V <sub>OUT</sub> =0V; V <sub>CC</sub> =13V; T <sub>j</sub> =25°C			3	µA

(\*\*) Per device

SWITCHING (V<sub>CC</sub>=13V)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
t <sub>d(on)</sub>	Turn-on Delay Time	R <sub>L</sub> =13Ω from V <sub>IN</sub> rising edge to V <sub>OUT</sub> =1.3V		30		µs
t <sub>d(off)</sub>	Turn-off Delay Time	R <sub>L</sub> =13Ω from V <sub>IN</sub> falling edge to V <sub>OUT</sub> =11.7V		30		µs
dV <sub>OUT</sub> /dt <sub>(on)</sub>	Turn-on Voltage Slope	R <sub>L</sub> =13Ω from V <sub>OUT</sub> =1.3V to V <sub>OUT</sub> =10.4V		See relative diagram		V/µs
dV <sub>OUT</sub> /dt <sub>(off)</sub>	Turn-off Voltage Slope	R <sub>L</sub> =13Ω from V <sub>OUT</sub> =11.7V to V <sub>OUT</sub> =1.3V		See relative diagram		V/µs

## LOGIC INPUT

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V <sub>IL</sub>	Input Low Level				1.25	V
I <sub>IL</sub>	Low Level Input Current	V <sub>IN</sub> = 1.25V	1			µA
V <sub>IH</sub>	Input High Level		3.25			V
I <sub>IH</sub>	High Level Input Current	V <sub>IN</sub> = 3.25V			10	µA
V <sub>I(hyst)</sub>	Input Hysteresis Voltage		0.5			V
V <sub>ICL</sub>	Input Clamp Voltage	I <sub>IN</sub> = 1mA I <sub>IN</sub> = -1mA	6	6.8 -0.7	8	V V

**ELECTRICAL CHARACTERISTICS** (continued)

V<sub>CC</sub> - OUTPUT DIODE

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V <sub>F</sub>	Forward on Voltage	-I <sub>OUT</sub> =0.5A; T <sub>j</sub> =150°C			0.6	V

STATUS PIN

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V <sub>STAT</sub>	Status Low Output Voltage	I <sub>STAT</sub> = 1.6 mA			0.5	V
I <sub>LSTAT</sub>	Status Leakage Current	Normal Operation; V <sub>STAT</sub> = 5V			10	μA
C <sub>STAT</sub>	Status Pin Input Capacitance	Normal Operation; V <sub>STAT</sub> = 5V			100	pF
V <sub>SCL</sub>	Status Clamp Voltage	I <sub>STAT</sub> = 1mA	6	6.8	8	V
		I <sub>STAT</sub> = - 1mA		-0.7		V

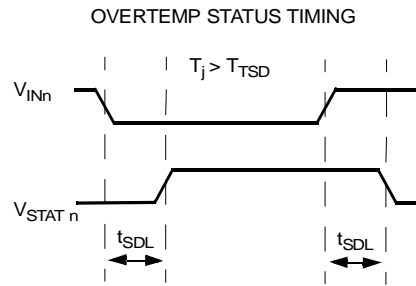
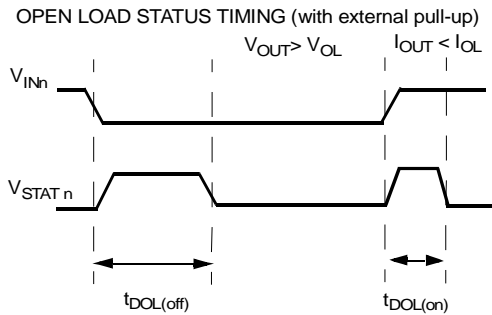
PROTECTIONS (see note 1)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
T <sub>TSD</sub>	Shut-down Temperature		150	175	200	°C
T <sub>R</sub>	Reset Temperature		135			°C
T <sub>hyst</sub>	Thermal Hysteresis		7	15		°C
t <sub>SDL</sub>	Status Delay in Overload Conditions	T <sub>j</sub> >T <sub>TSD</sub>			20	μs
I <sub>lim</sub>	Current limitation	5.5V<V <sub>CC</sub> <36V	3.5	5	7.5	A
					7.5	A
V <sub>demag</sub>	Turn-off Output Clamp Voltage	I <sub>OUT</sub> =1A; L=6mH	V <sub>CC</sub> -41	V <sub>CC</sub> -48	V <sub>CC</sub> -55	V

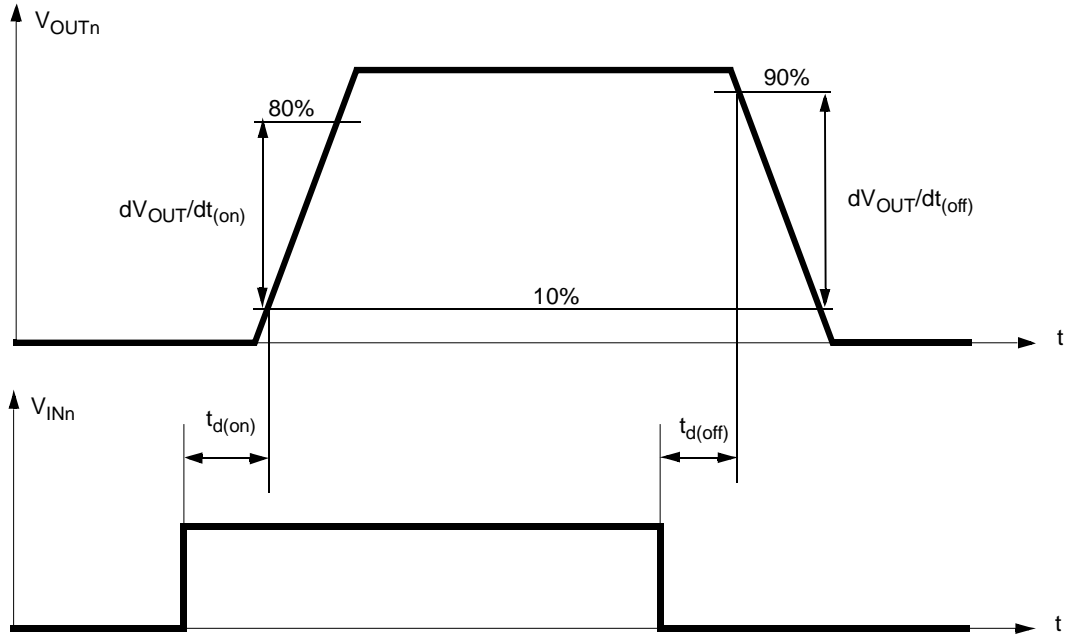
Note 1: To ensure long term reliability under heavy overload or short circuit conditions, protection and related diagnostic signals must be used together with a proper software strategy. If the device is subjected to abnormal conditions, this software must limit the duration and number of activation cycles.

OPENLOAD DETECTION

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
I <sub>OL</sub>	Openload ON State Detection Threshold	V <sub>IN</sub> =5V	20	40	80	mA
t <sub>DOL(on)</sub>	Openload ON State Detection Delay	I <sub>OUT</sub> =0A			200	μs
V <sub>OL</sub>	Openload OFF State Voltage Detection Threshold	V <sub>IN</sub> =0V	1.5	2.5	3.5	V
t <sub>DOL(off)</sub>	Openload Detection Delay at Turn Off				1000	μs



Switching time Waveforms



TRUTH TABLE

CONDITIONS	INPUT	OUTPUT	STATUS
Normal Operation	L	L	H
	H	H	H
Current Limitation	L	L	H
	H	X	$(T_j < T_{TSD})$ H $(T_j > T_{TSD})$ L
Overtemperature	L	L	H
	H	L	L
Undervoltage	L	L	X
	H	L	X
Overvoltage	L	L	H
	H	L	H
Output Voltage > $V_{OL}$	L	H	L
	H	H	H
Output Current < $I_{OL}$	L	L	H
	H	H	L

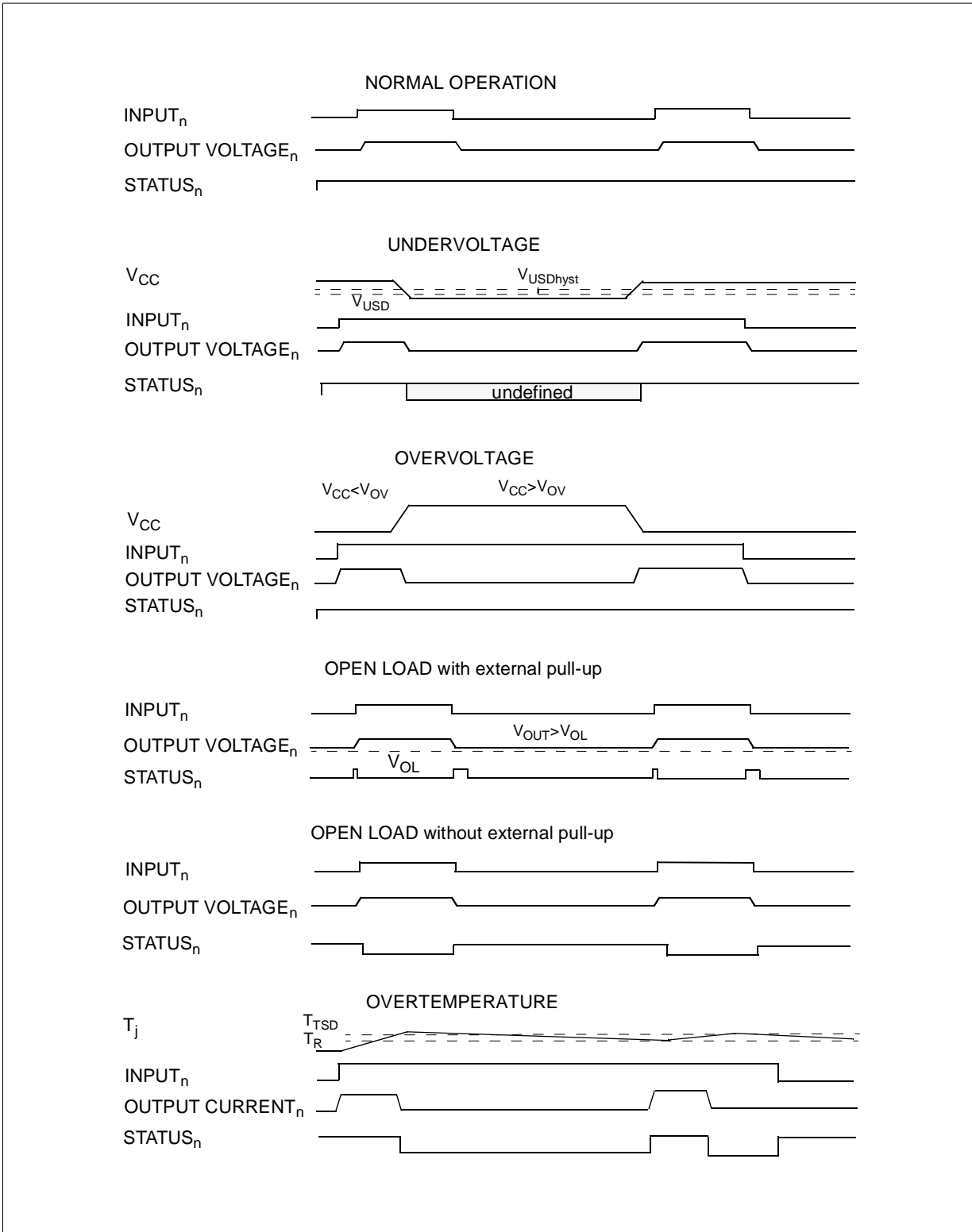
ELECTRICAL TRANSIENT REQUIREMENTS ON V<sub>CC</sub> PIN

ISO T/R 7637/1 Test Pulse	TEST LEVELS				Delays and Impedance
	I	II	III	IV	
1	-25 V	-50 V	-75 V	-100 V	2 ms 10 Ω
2	+25 V	+50 V	+75 V	+100 V	0.2 ms 10 Ω
3a	-25 V	-50 V	-100 V	-150 V	0.1 μs 50 Ω
3b	+25 V	+50 V	+75 V	+100 V	0.1 μs 50 Ω
4	-4 V	-5 V	-6 V	-7 V	100 ms, 0.01 Ω
5	+26.5 V	+46.5 V	+66.5 V	+86.5 V	400 ms, 2 Ω

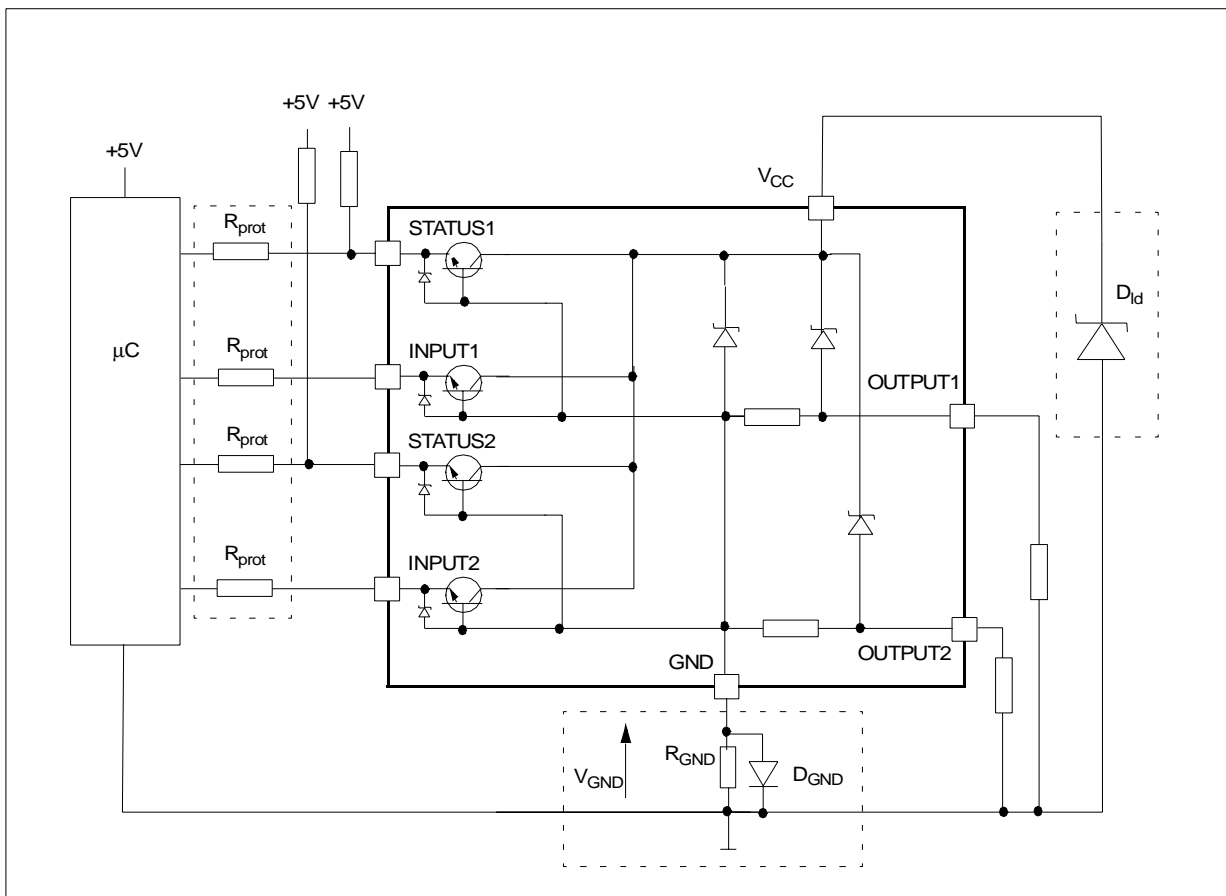
ISO T/R 7637/1 Test Pulse	TEST LEVELS RESULTS			
	I	II	III	IV
1	C	C	C	C
2	C	C	C	C
3a	C	C	C	C
3b	C	C	C	C
4	C	C	C	C
5	C	E	E	E

CLASS	CONTENTS
C	All functions of the device are performed as designed after exposure to disturbance.
E	One or more functions of the device is not performed as designed after exposure and cannot be returned to proper operation without replacing the device.

Figure 1: Waveforms



APPLICATION SCHEMATIC



**GND PROTECTION NETWORK AGAINST REVERSE BATTERY**

**Solution 1:** Resistor in the ground line ( $R_{GND}$  only). This can be used with any type of load.

The following is an indication on how to dimension the  $R_{GND}$  resistor.

- 1)  $R_{GND} \leq 600mV / I_{S(on)max}$
- 2)  $R_{GND} \geq (-V_{CC}) / (-I_{GND})$

where  $-I_{GND}$  is the DC reverse ground pin current and can be found in the absolute maximum rating section of the device's datasheet.

Power Dissipation in  $R_{GND}$  (when  $V_{CC} < 0$ : during reverse battery situations) is:

$$P_D = (-V_{CC})^2 / R_{GND}$$

This resistor can be shared amongst several different HSD. Please note that the value of this resistor should be calculated with formula (1) where  $I_{S(on)max}$  becomes the sum of the maximum on-state currents of the different devices.

Please note that if the microprocessor ground is not common with the device ground then the  $R_{GND}$  will produce a shift ( $I_{S(on)max} * R_{GND}$ ) in the input thresholds and the status output values. This shift will vary

depending on how many devices are ON in the case of several high side drivers sharing the same  $R_{GND}$ .

If the calculated power dissipation leads to a large resistor or several devices have to share the same resistor then the ST suggests to utilize Solution 2 (see below).

**Solution 2:** A diode ( $D_{GND}$ ) in the ground line.

A resistor ( $R_{GND} = 1k\Omega$ ) should be inserted in parallel to  $D_{GND}$  if the device will be driving an inductive load.

This small signal diode can be safely shared amongst several different HSD. Also in this case, the presence of the ground network will produce a shift ( $\approx 600mV$ ) in the input threshold and the status output values if the microprocessor ground is not common with the device ground. This shift will not vary if more than one HSD shares the same diode/resistor network.

Series resistor in INPUT and STATUS lines are also required to prevent that, during battery voltage transient, the current exceeds the Absolute Maximum Rating.

Safest configuration for unused INPUT and STATUS pin is to leave them unconnected.



**LOAD DUMP PROTECTION**

$D_{ld}$  is necessary (Voltage Transient Suppressor) if the load dump peak voltage exceeds  $V_{CC}$  max DC rating. The same applies if the device will be subject to transients on the  $V_{CC}$  line that are greater than the ones shown in the ISO T/R 7637/1 table.

**µC I/Os PROTECTION:**

If a ground protection network is used and negative transients are present on the  $V_{CC}$  line, the control pins will be pulled negative. ST suggests to insert a resistor ( $R_{prot}$ ) in line to prevent the µC I/Os pins to latch-up.

The value of these resistors is a compromise between the leakage current of µC and the current required by the HSD I/Os (Input levels compatibility) with the latch-up limit of µC I/Os.

$$-V_{CCpeak} / I_{latchup} \leq R_{prot} \leq (V_{OH\mu C} - V_{IH} - V_{GND}) / I_{IHmax}$$

Calculation example:

For  $V_{CCpeak} = -100V$  and  $I_{latchup} \geq 20mA$ ;  $V_{OH\mu C} \geq 4.5V$

$$5k\Omega \leq R_{prot} \leq 65k\Omega$$

Recommended  $R_{prot}$  value is 10kΩ.

**OPEN LOAD DETECTION IN OFF STATE**

Off state open load detection requires an external pull-up resistor ( $R_{PU}$ ) connected between OUTPUT pin and a positive supply voltage ( $V_{PU}$ ) like the +5V line used to supply the microprocessor.

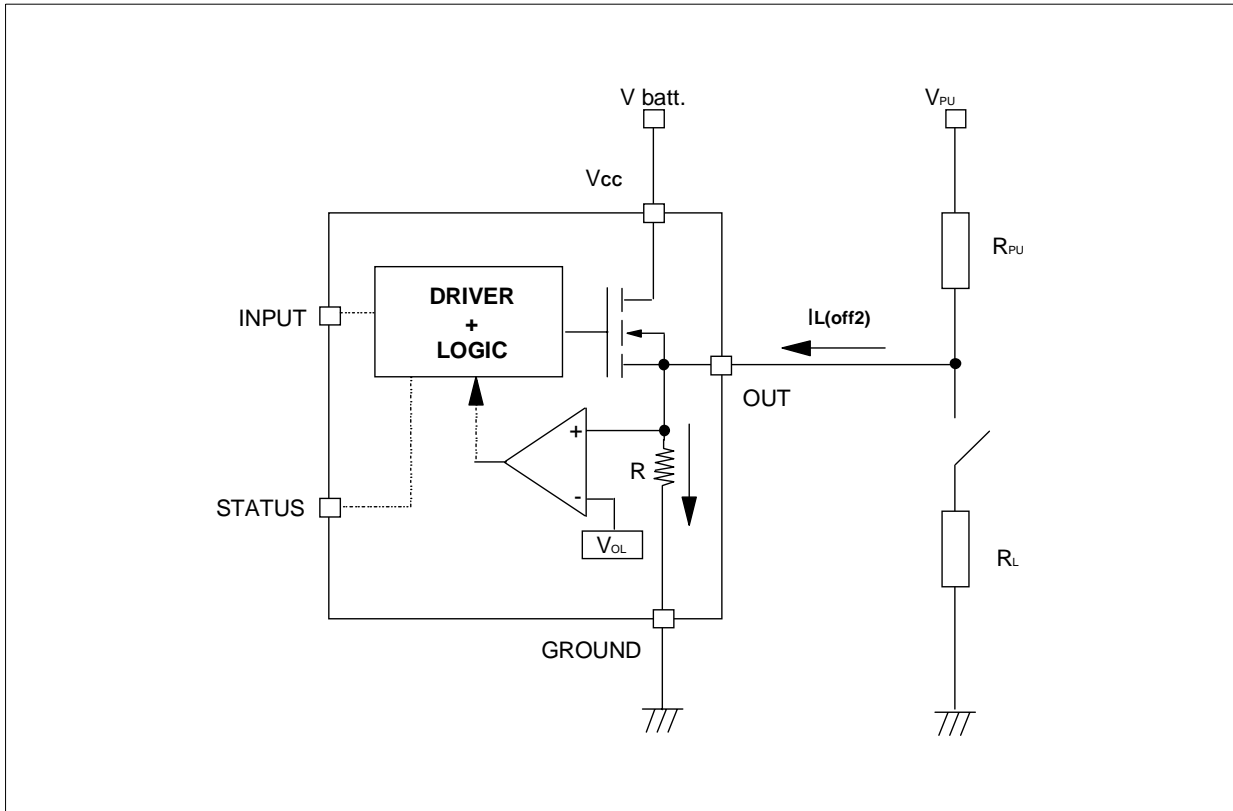
The external resistor has to be selected according to the following requirements:

- 1) no false open load indication when load is connected: in this case we have to avoid  $V_{OUT}$  to be higher than  $V_{OLmin}$ ; this results in the following condition  $V_{OUT} = (V_{PU} / (R_L + R_{PU})) R_L < V_{OLmin}$ .
- 2) no misdetection when load is disconnected: in this case the  $V_{OUT}$  has to be higher than  $V_{OLmax}$ ; this results in the following condition  $R_{PU} < (V_{PU} - V_{OLmax}) / I_{L(off2)}$ .

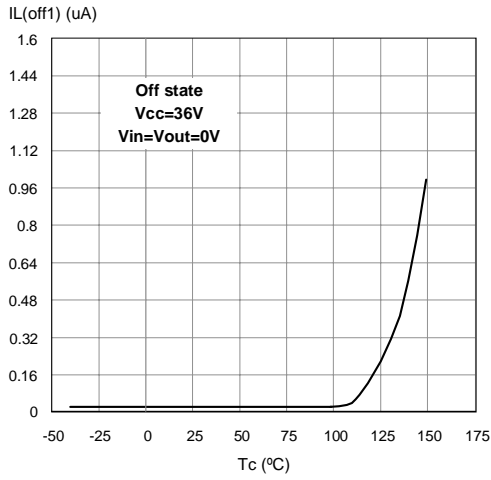
Because  $I_{s(OFF)}$  may significantly increase if  $V_{out}$  is pulled high (up to several mA), the pull-up resistor  $R_{PU}$  should be connected to a supply that is switched OFF when the module is in standby.

The values of  $V_{OLmin}$ ,  $V_{OLmax}$  and  $I_{L(off2)}$  are available in the Electrical Characteristics section.

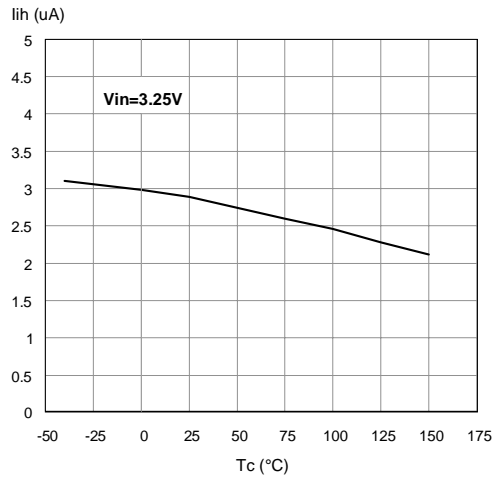
**Open Load detection in off state**



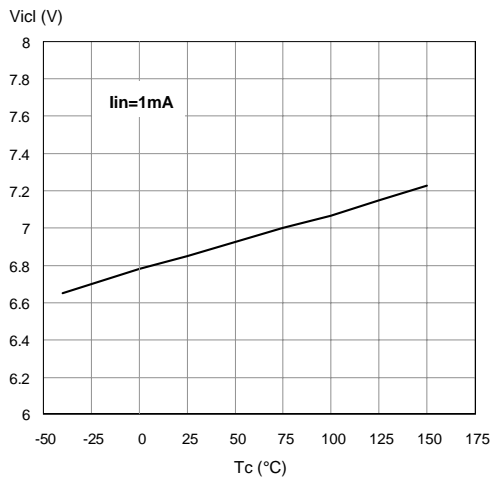
Off State Output Current



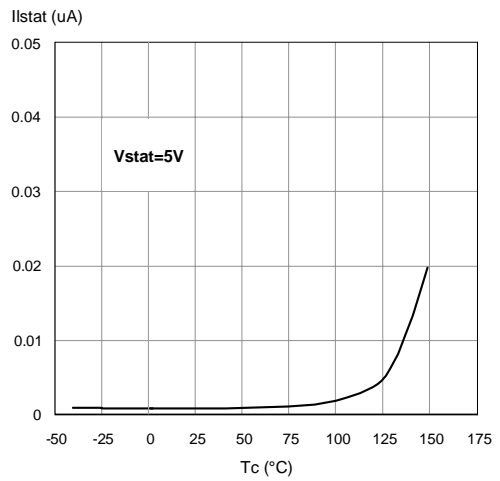
High Level Input Current



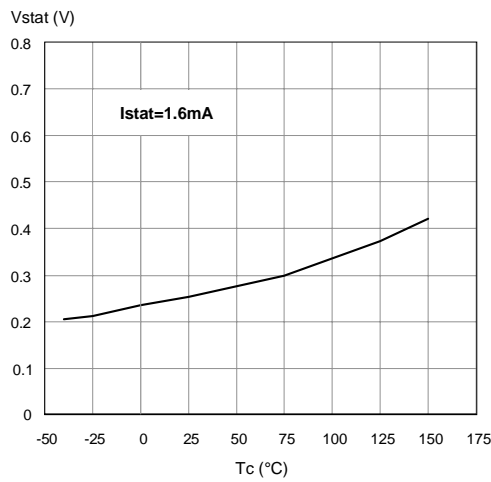
Input Clamp Voltage



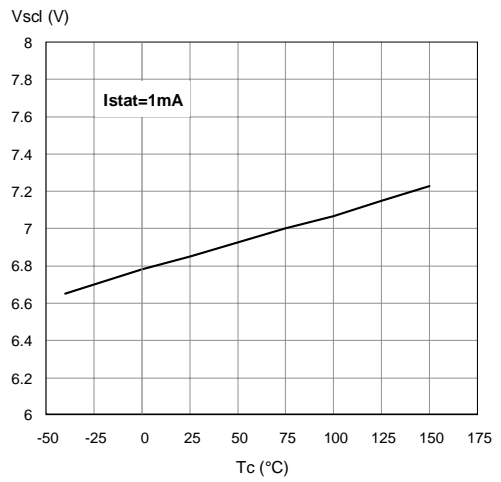
Status Leakage Current



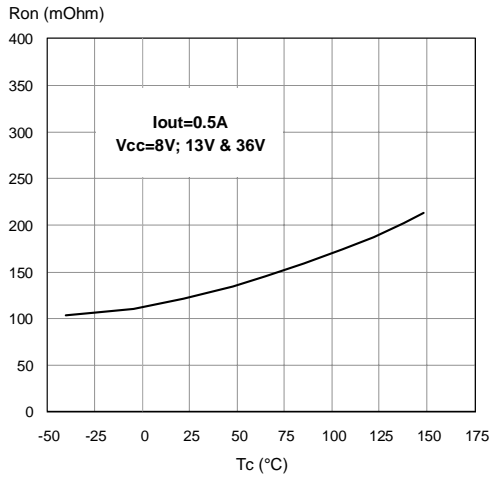
Status Low Output Voltage



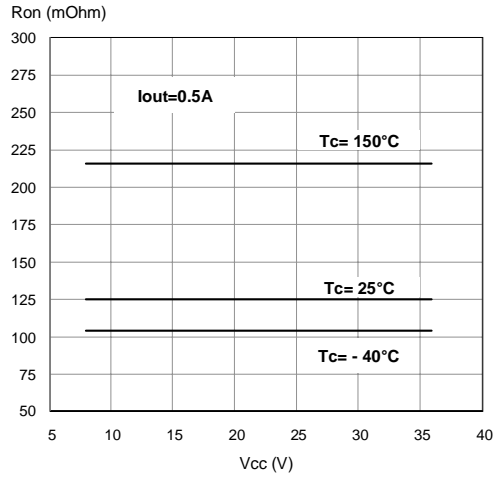
Status Clamp Voltage



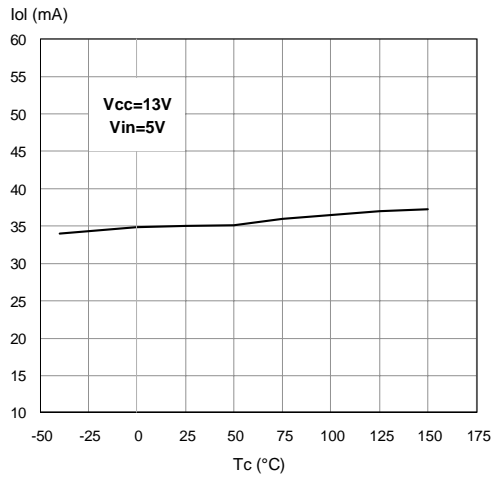
On State Resistance Vs  $T_{case}$



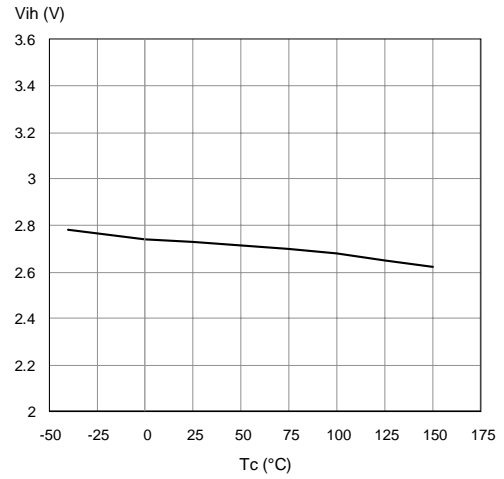
On State Resistance Vs  $V_{CC}$



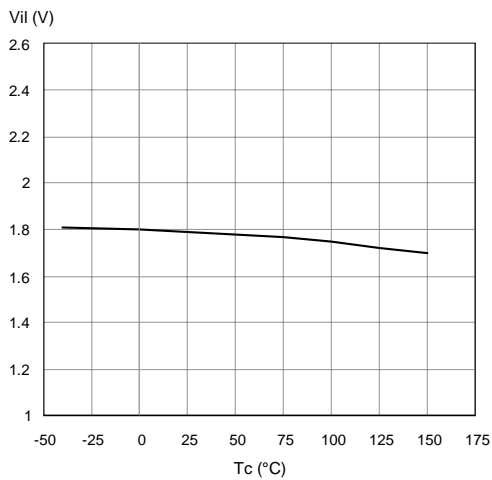
Openload On State Detection Threshold



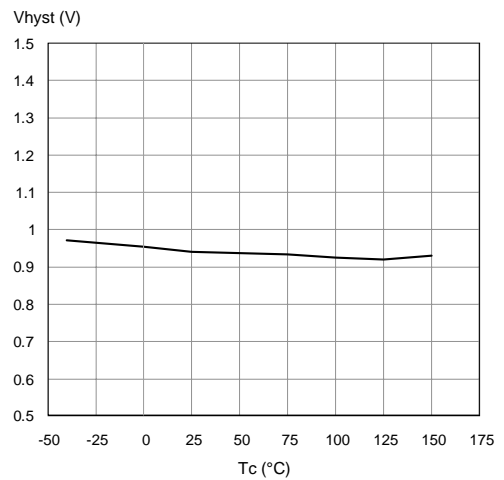
Input High Level



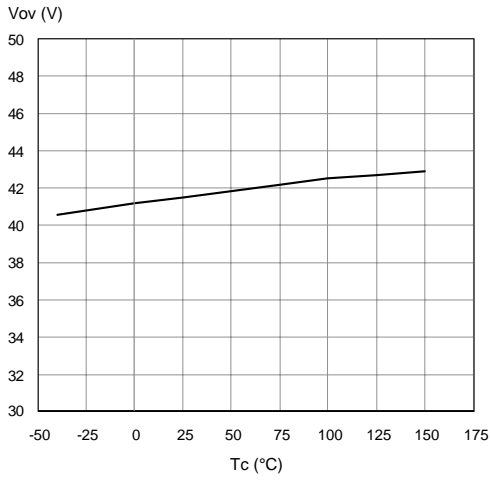
Input Low Level



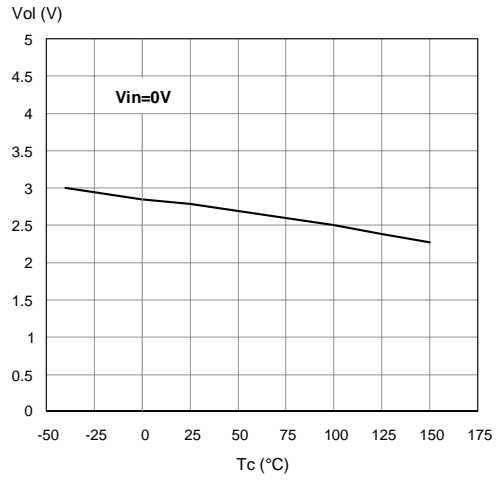
Input Hysteresis Voltage



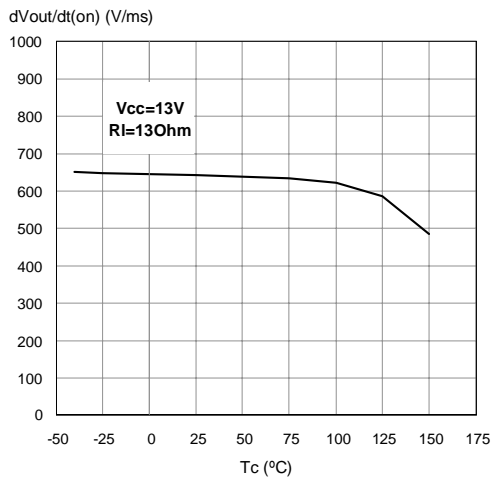
Overvoltage Shutdown



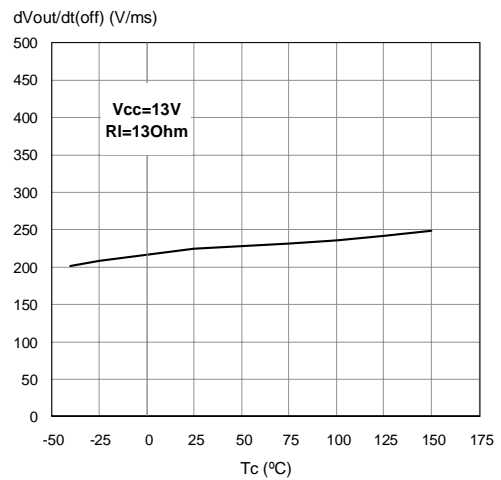
Openload Off State Voltage Detection Threshold



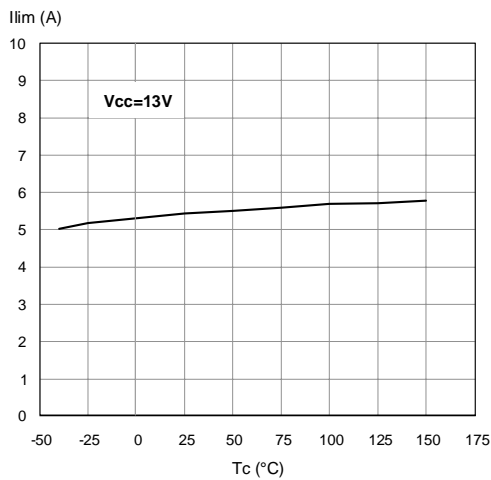
Turn-on Voltage Slope



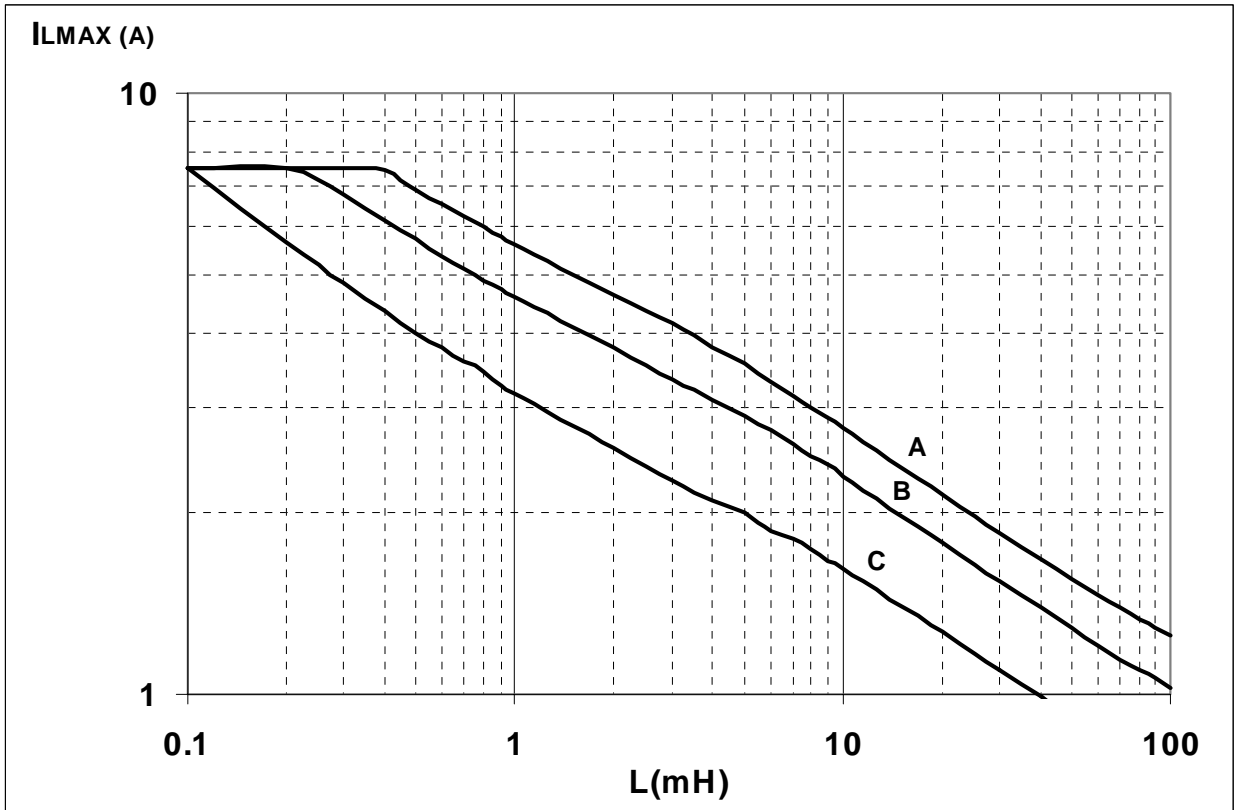
Turn-off Voltage Slope



I<sub>LIM</sub> Vs T<sub>case</sub>



Maximum turn off current versus load inductance



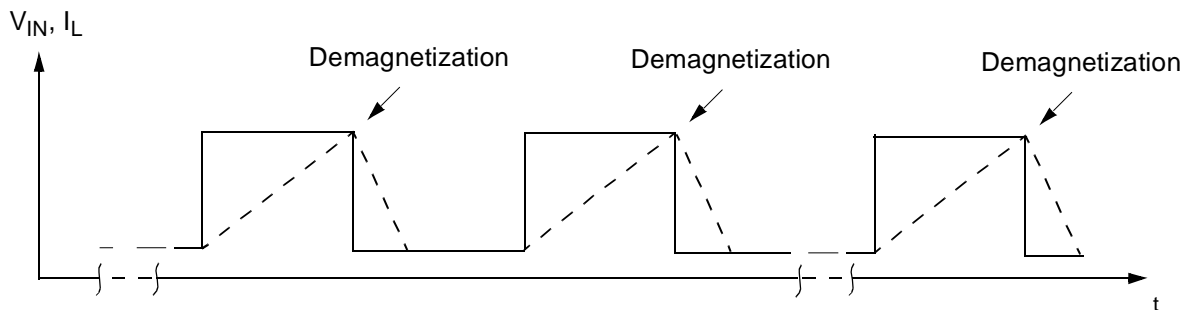
- A = Single Pulse at  $T_{Jstart}=150^{\circ}C$
- B= Repetitive pulse at  $T_{Jstart}=100^{\circ}C$
- C= Repetitive Pulse at  $T_{Jstart}=125^{\circ}C$

Conditions:

$V_{CC}=13.5V$


Values are generated with  $R_L=0\Omega$

In case of repetitive pulses,  $T_{jstart}$  (at beginning of each demagnetization) of every pulse must not exceed the temperature specified above for curves B and C.



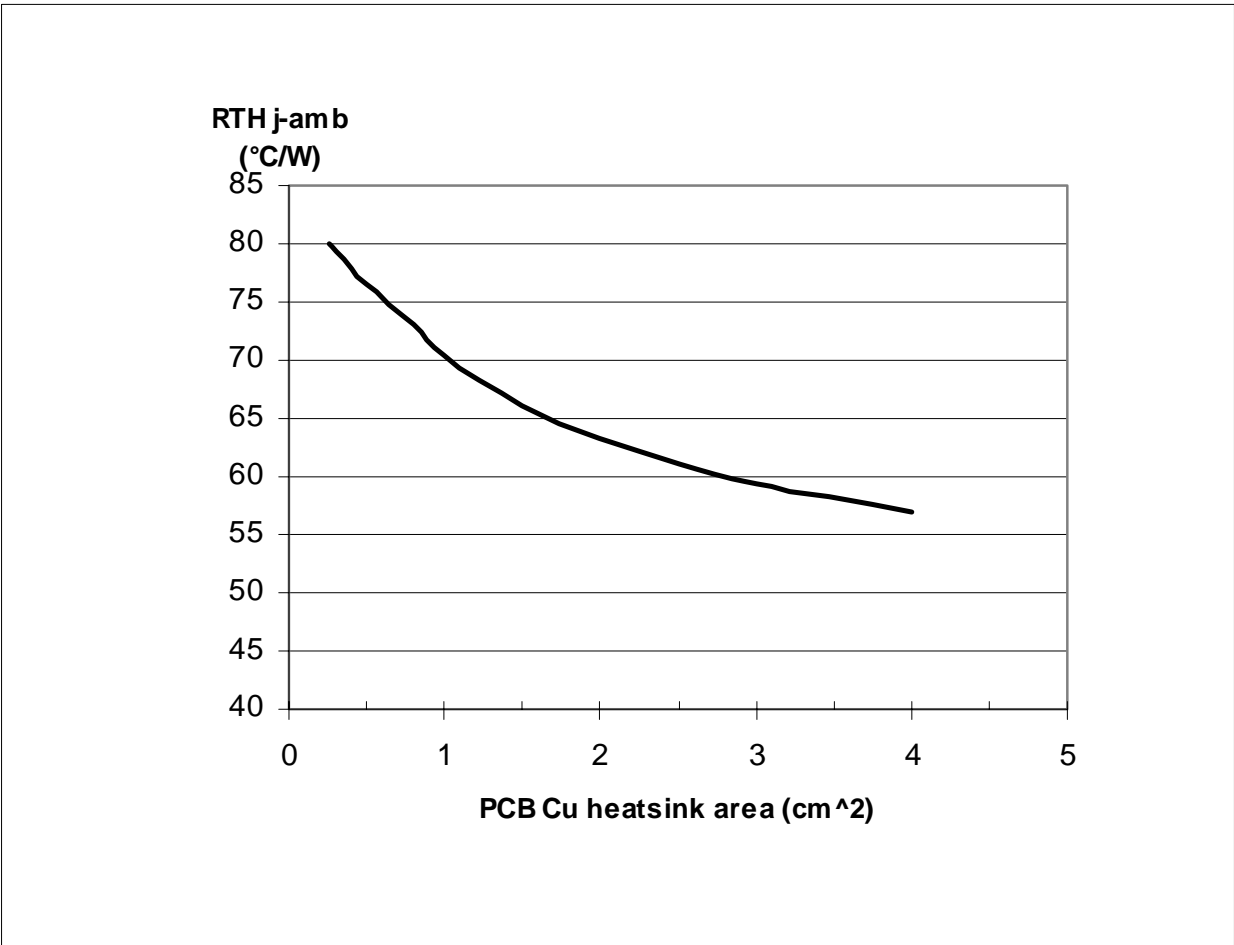
**SO-16 THERMAL DATA**

**SO-16 PC Board**

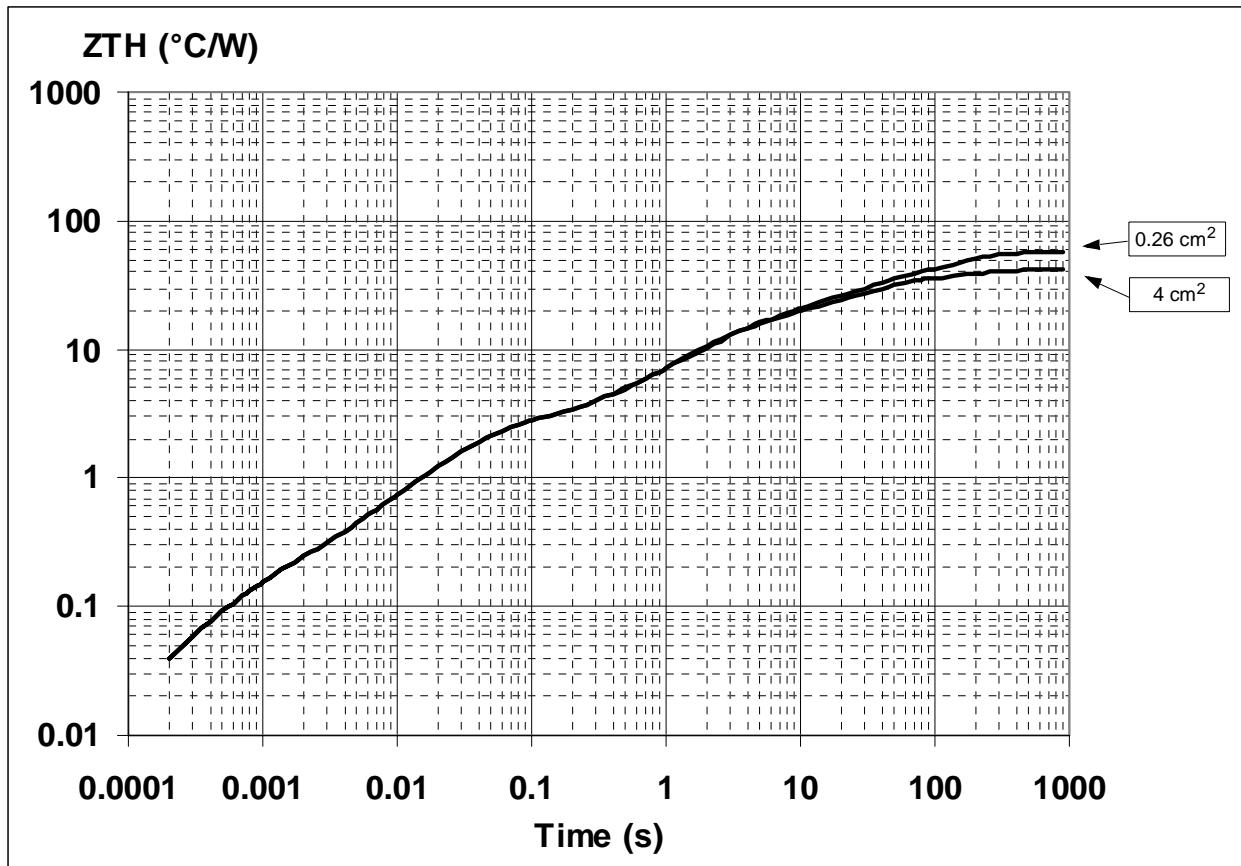


Layout condition of  $R_{th}$  and  $Z_{th}$  measurements (PCB FR4 area= 58mm x 58mm, PCB thickness=1.6mm, Cu thickness=35 $\mu$ m, Copper areas: 0.26cm<sup>2</sup>, 4cm<sup>2</sup>).

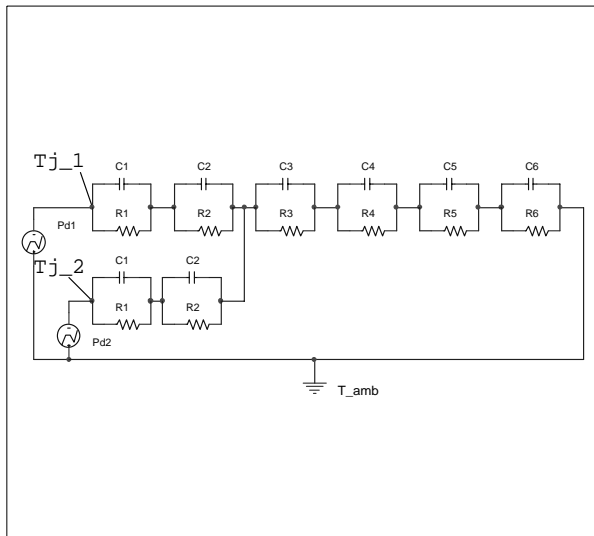
**$R_{thj-amb}$  Vs PCB copper area in open box free air condition**



SO-16 Thermal Impedance Junction Ambient Single Pulse



Thermal fitting model of a double channel HSD in SO-16



Pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

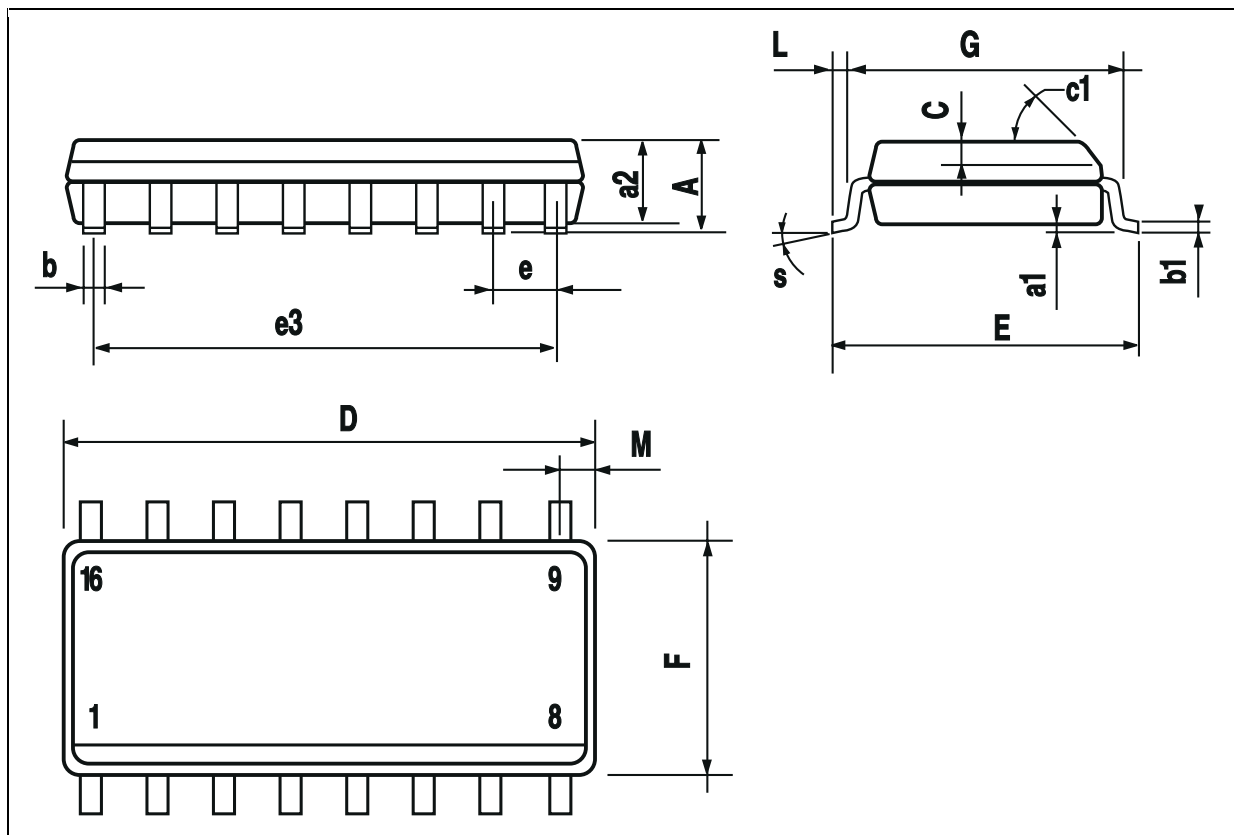
where  $\delta = t_p/T$

Thermal Parameter

Area/island (cm <sup>2</sup> )	0.5	4
R1 (°C/W)	0.35	
R2 (°C/W)	1.8	
R3 (°C/W)	4.5	
R4 (°C/W)	10	
R5 (°C/W)	16	
R6 (°C/W)	48	25
C1 (W.s/°C)	0.0001	
C2 (W.s/°C)	7.00E-04	
C3 (W.s/°C)	6.00E-03	
C4 (W.s/°C)	0.2	
C5 (W.s/°C)	0.7	
C6 (W.s/°C)	2	4

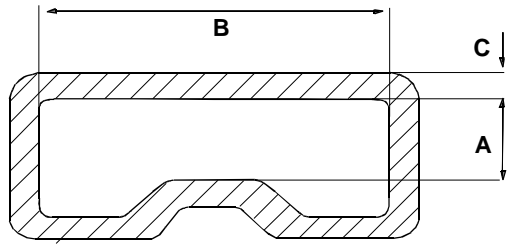
**SO-16 MECHANICAL DATA**

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.2	0.004		0.007
a2			1.65			0.064
b	0.35		0.46	0.013		0.018
b1	0.19		0.25	0.007		0.010
C		0.5			0.019	
c1	45° (typ.)					
D	9.8		10	0.385		0.393
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		8.89			0.350	
F	3.8		4.0	0.149		1.157
G	4.6		5.3	0.181		0.208
L	0.5		1.27	0.019		0.050
M			0.62			0.024
S	8° (max.)					





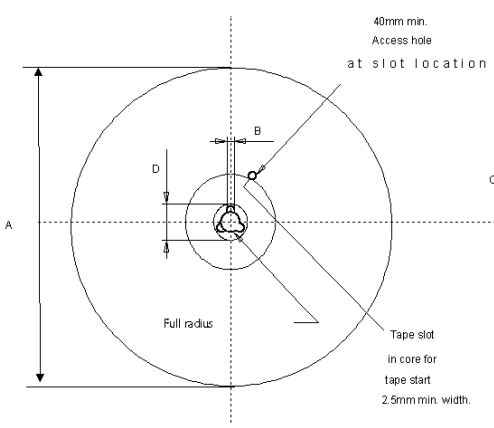
**SO-16 TUBE SHIPMENT (no suffix)**



<b>Base Q.ty</b>	50
<b>Bulk Q.ty</b>	1000
<b>Tube length (± 0.5)</b>	532
<b>A</b>	3.2
<b>B</b>	6
<b>C (± 0.1)</b>	0.6

All dimensions are in mm.

**TAPE AND REEL SHIPMENT (suffix "13TR")**



40mm min. Access hole at slot location

Full radius

Tape slot in core for tape start 2.5mm min. width.

**REEL DIMENSIONS**

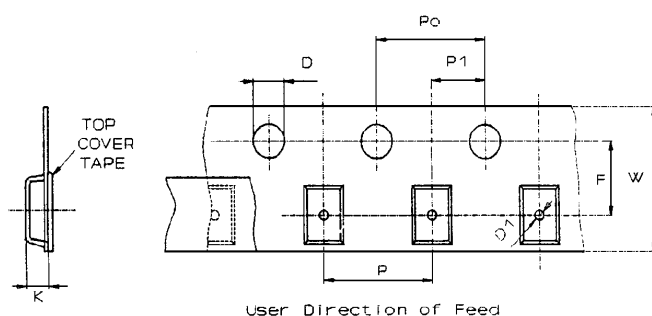
<b>Base Q.ty</b>	1000
<b>Bulk Q.ty</b>	1000
<b>A (max)</b>	330
<b>B (min)</b>	1.5
<b>C (± 0.2)</b>	13
<b>F</b>	20.2
<b>G (+ 2 / -0)</b>	16.4
<b>N (min)</b>	60
<b>T (max)</b>	22.4

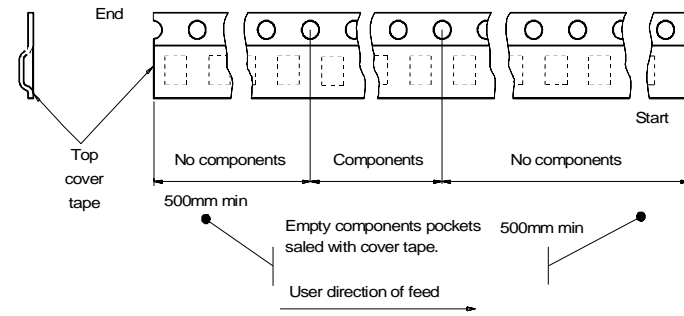
All dimensions are in mm.

**TAPE DIMENSIONS**  
According to Electronic Industries Association (EIA) Standard 481 rev. A, Feb 1986

<b>Tape width</b>	<b>W</b>	16
<b>Tape Hole Spacing</b>	<b>P0 (± 0.1)</b>	4
<b>Component Spacing</b>	<b>P</b>	8
<b>Hole Diameter</b>	<b>D (± 0.1/-0)</b>	1.5
<b>Hole Diameter</b>	<b>D1 (min)</b>	1.5
<b>Hole Position</b>	<b>F (± 0.05)</b>	7.5
<b>Compartment Depth</b>	<b>K (max)</b>	6.5
<b>Hole Spacing</b>	<b>P1 (± 0.1)</b>	2

All dimensions are in mm.





500mm min Empty components pockets sealed with cover tape.

500mm min

User direction of feed

**REVISION HISTORY**

Date	Revision	Description of Changes
Jul 2004	1	<ul style="list-style-type: none"><li>- Current and voltage convention update (page 2).</li><li>- "Configuration diagram (top view) &amp; suggested connections for unused and n.c. pins" insertion (page 2).</li><li>- 4 cm<sup>2</sup> Cu condition insertion in Thermal Data table (page 3).</li><li>- V<sub>CC</sub> - OUTPUT DIODE section update (page 4).</li><li>- PROTECTIONS note insertion (page 4).</li><li>- Revision History table insertion (page 18).</li><li>- Disclaimers update (page 19).</li></ul>

Information furnished is believed to be accurate and reliable. However, STMicroelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of STMicroelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. STMicroelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of STMicroelectronics.

The ST logo is a trademark of STMicroelectronics.  
All other names are the property of their respective owners

© 2004 STMicroelectronics - Printed in ITALY- All Rights Reserved.

**STMicroelectronics GROUP OF COMPANIES**

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan -  
Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States  
<http://www.st.com>

